

Normally – OFF Silicon Carbide Junction Transistor

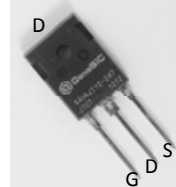
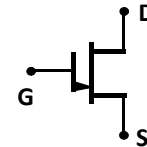
| | | |
|--------------|---|---------------|
| V_{DS} | = | 1200 V |
| $V_{DS(ON)}$ | = | 1.3 V |
| I_D | = | 6 A |
| $R_{DS(ON)}$ | = | 220 mΩ |

Features

- 175 °C maximum operating temperature
- Temperature independent switching performance
- Gate oxide free SiC switch
- Suitable for connecting an anti-parallel diode
- Positive temperature coefficient for easy paralleling
- Low gate charge
- Low intrinsic capacitance

Package

- RoHS Compliant


TO-247AB


Advantages

- Low switching losses
- Higher efficiency
- High temperature operation
- High short circuit withstand capability

Applications

- Down Hole Oil Drilling, Geothermal Instrumentation
- Hybrid Electric Vehicles (HEV)
- Solar Inverters
- Switched-Mode Power Supply (SMPS)
- Power Factor Correction (PFC)
- Induction Heating
- Uninterruptible Power Supply (UPS)
- Motor Drives

Maximum Ratings unless otherwise specified

| Parameter | Symbol | Conditions | Values | Unit |
|-----------------------------------|-----------|---|--|---------|
| Drain – Source Voltage | V_{DS} | $V_{GS} = 0 V$ | 1200 | V |
| Continuous Drain Current | I_D | $T_{C,MAX} = 90 °C$ | 6 | A |
| Gate Peak Current | I_{GM} | | 5 | A |
| Turn-Off Safe Operating Area | RBSOA | $T_{VJ} = 175 °C, I_G = 1 A,$ Clamped Inductive Load | $I_{D,max} = 6$ @ $V_{DS} \leq V_{DSmax}$ | A |
| Short Circuit Safe Operating Area | SCSOA | $T_{VJ} = 175 °C, I_G = 1 A, V_{DS} = 800 V,$ Non Repetitive | 20 | μs |
| Reverse Gate – Source Voltage | V_{SG} | | 30 | V |
| Reverse Drain – Source Voltage | V_{SD} | | 40 | V |
| Power Dissipation | P_{tot} | $T_C = 25 °C$ | 146 | W |
| Storage Temperature | T_{stg} | | -55 to 175 | $°C$ |

Electrical Characteristics at $T_j = 175 °C$, unless otherwise specified

| Parameter | Symbol | Conditions | Values | | | Unit |
|------------------------------|---------------|---|--------|------------|------|---------|
| | | | min. | typ. | max. | |
| On Characteristics | | | | | | |
| Drain – Source On Voltage | $V_{DS(ON)}$ | $I_D = 6 A, I_G = 500 mA, T_j = 25 °C$ | | 1.3 | 1.7 | V |
| | | $I_D = 6 A, I_G = 1000 mA, T_j = 125 °C$ | | 1.7 | 2.2 | |
| | | $I_D = 6 A, I_G = 1000 mA, T_j = 175 °C$ | | 2.2 | 3.0 | |
| Drain – Source On Resistance | $R_{DS(ON)}$ | $I_D = 6 A, I_G = 500 mA, T_j = 25 °C$ | | 220 | | mΩ |
| | | $I_D = 6 A, I_G = 1000 mA, T_j = 125 °C$ | | 280 | | |
| | | $I_D = 6 A, I_G = 1000 mA, T_j = 175 °C$ | | 370 | | |
| Gate Forward Voltage | $V_{GS(FWD)}$ | $I_G = 500 mA, T_j = 25 °C$ $I_G = 500 mA, T_j = 175 °C$ | | 3.1 2.9 | | V |
| DC Current Gain | β | $V_{DS} = 5 V, I_D = 6 A, T_j = 25 °C$ | 45 | 53 | | |
| | | $V_{DS} = 5 V, I_D = 6 A, T_j = 175 °C$ | | 33 | | |
| Off Characteristics | | | | | | |
| Drain Leakage Current | I_{DSS} | $V_R = 1200 V, V_{GS} = 0 V, T_j = 25 °C$ | | 0.5 | 10 | μA |
| | | $V_R = 1200 V, V_{GS} = 0 V, T_j = 125 °C$ | | 1 | 50 | |
| | | $V_R = 1200 V, V_{GS} = 0 V, T_j = 175 °C$ | | 2 | 100 | |
| Gate Leakage Current | I_{SG} | $V_{SG} = 20 V, T_j = 25 °C$ | | 20 | | nA |

Electrical Characteristics at $T_j = 175^\circ\text{C}$, unless otherwise specified

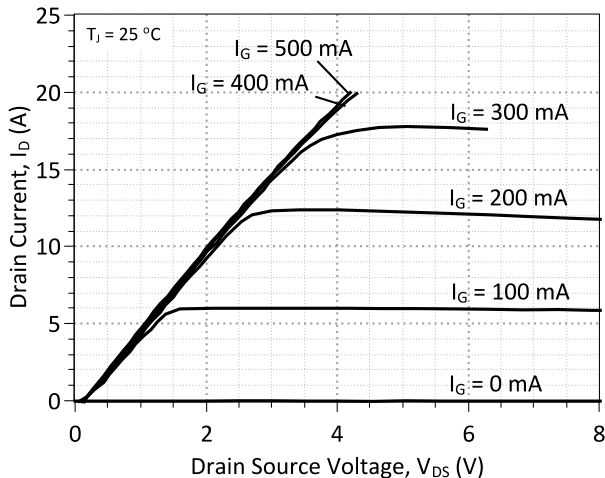
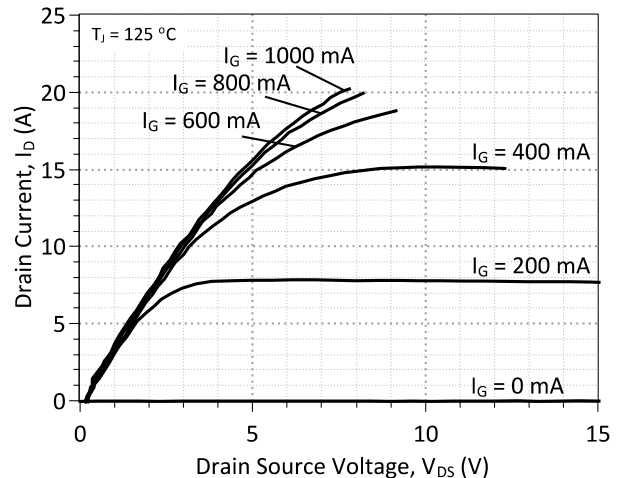
| Parameter | Symbol | Conditions | Values | | | Unit |
|-------------------------------------|-------------------|---|--------|------|------|------|
| | | | min. | typ. | max. | |
| Capacitance Characteristics | | | | | | |
| Gate-Source Capacitance | C_{GS} | $V_{GS} = 0\text{ V}, f = 1\text{ MHz}$ | | 660 | | pF |
| Input Capacitance | C_{ISS} | $V_{GS} = 0\text{ V}, V_D = 1\text{ V}, f = 1\text{ MHz}$ | | 900 | | pF |
| Reverse Transfer/Output Capacitance | C_{RSS}/C_{OSS} | $V_D = 1\text{ V}, f = 1\text{ MHz}$ | | 240 | | pF |

Switching Characteristics

| | | | | | | | |
|---------------------------|--------------|--|---|----|---------------|----|----|
| Turn On Delay Time | $t_{d(on)}$ | $T_j = 25^\circ\text{C}, V_{DD} = 800\text{ V}, I_D = 6\text{ A},$ "Option #1" Gate Drive $R_{G(on)} = R_{G(off)} = 1.5\ \Omega, C_G = 9\text{ nF}$ $V_{GH} = 20\text{ V}, V_{GL} = 6\text{ V}, V_{EE} = -5\text{ V}$ $L = 1.05\text{ mH}, \text{FWD} = \text{GB05SLT12},$ Refer to Figure 15 for gate current waveform | | 13 | | ns | |
| Rise Time, Drain Current | t_r | | 7 | | ns | | |
| Turn Off Delay Time | $t_{d(off)}$ | | 54 | | ns | | |
| Fall Time, Drain Current | t_f | | 51 | | ns | | |
| Turn-On Energy Per Pulse | E_{on} | | 175 | | μJ | | |
| Turn-Off Energy Per Pulse | E_{off} | | 44 | | μJ | | |
| Total Switching Energy | E_{ts} | | 219 | | μJ | | |
| Turn On Delay Time | $t_{d(on)}$ | | $T_j = 175^\circ\text{C}, V_{DD} = 800\text{ V}, I_D = 6\text{ A},$ "Option #1" Gate Drive $R_{G(on)} = R_{G(off)} = 1.5\ \Omega, C_G = 9\text{ nF}$ $V_{GH} = 20\text{ V}, V_{GL} = 6\text{ V}, V_{EE} = -5\text{ V}$ $L = 1.05\text{ mH}, \text{FWD} = \text{GB05SLT12},$ Refer to Figure 15 for gate current waveform | | 11 | | ns |
| Rise Time, Drain Current | t_r | | | 8 | | ns | |
| Turn Off Delay Time | $t_{d(off)}$ | | | 79 | | ns | |
| Fall Time, Drain Current | t_f | 45 | | | ns | | |
| Turn-On Energy Per Pulse | E_{on} | 159 | | | μJ | | |
| Turn-Off Energy Per Pulse | E_{off} | 55 | | | μJ | | |
| Total Switching Energy | E_{ts} | 214 | | | μJ | | |

Thermal Characteristics

| | | | |
|-------------------------------------|--------------|------|--------------------|
| Thermal resistance, junction - case | $R_{th(jc)}$ | 1.03 | $^\circ\text{C/W}$ |
|-------------------------------------|--------------|------|--------------------|

Figures

Figure 1: Typical Output Characteristics at 25°C

Figure 2: Typical Output Characteristics at 125°C

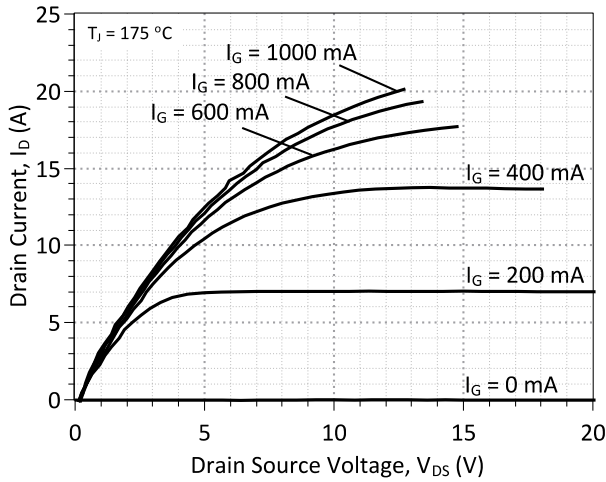


Figure 3: Typical Output Characteristics at 175 °C

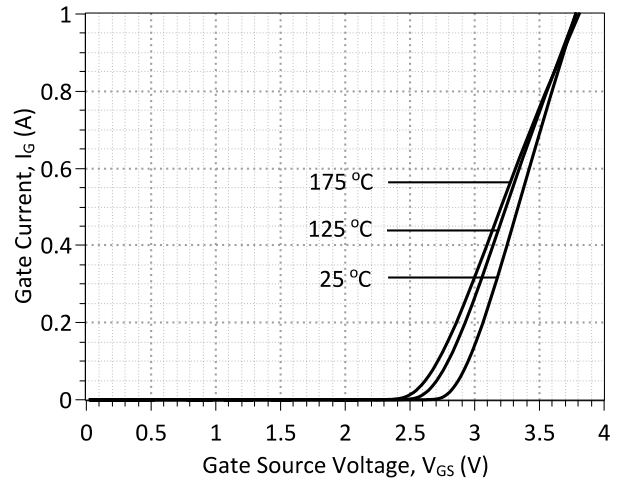


Figure 4: Typical Gate Source I-V Characteristics vs. Temperature

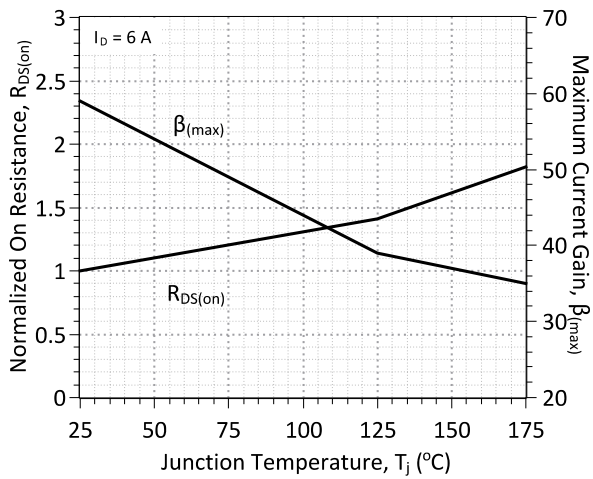


Figure 5: Normalized On-Resistance and Current Gain vs. Temperature

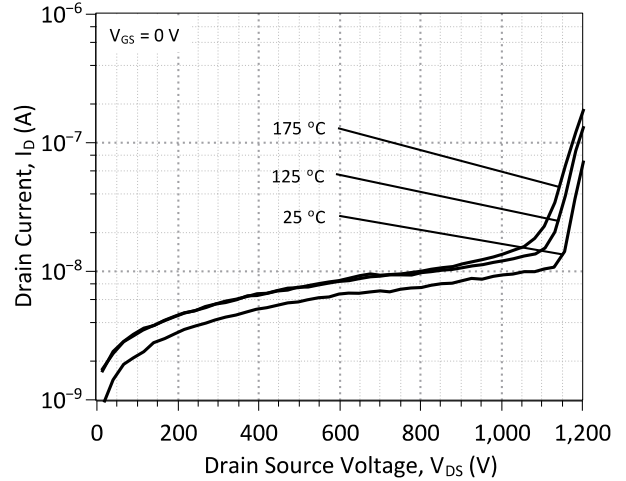


Figure 6: Typical Blocking Characteristics

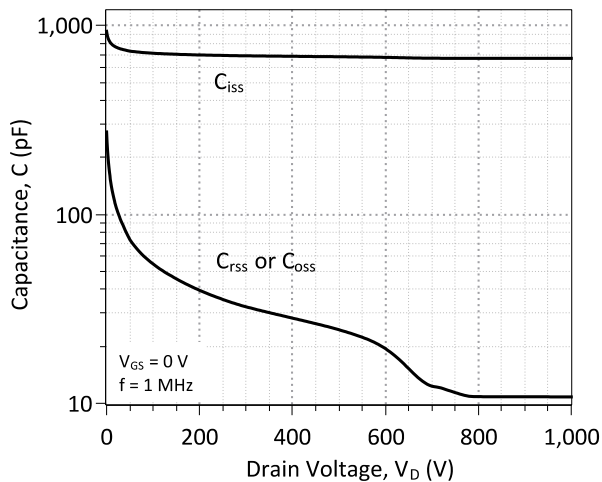


Figure 7: Capacitance Characteristics

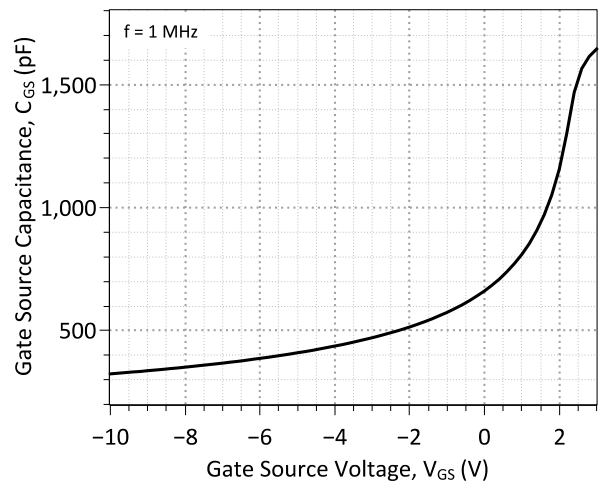


Figure 8: Capacitance Characteristics

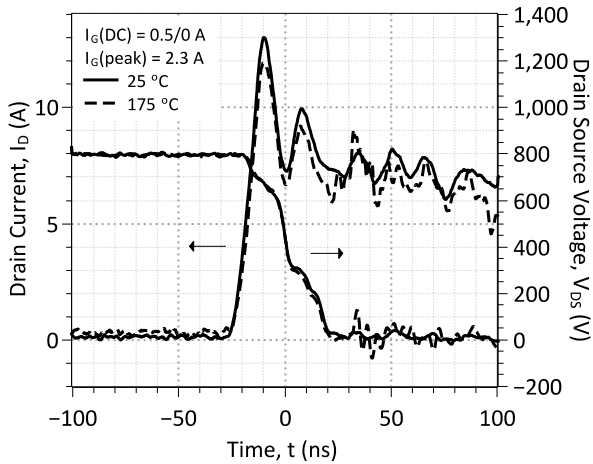


Figure 9: Typical Hard-switched Turn On Waveforms

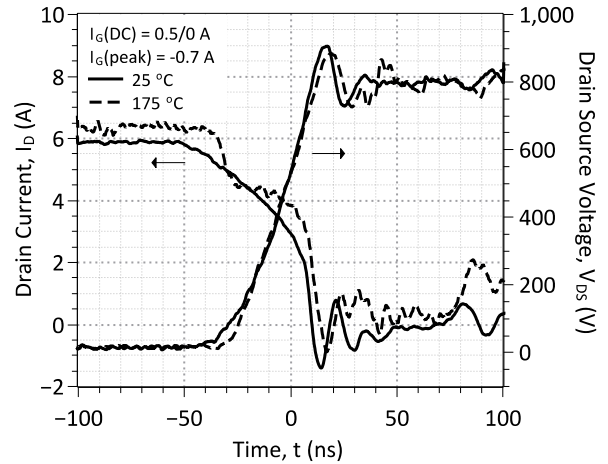


Figure 10: Typical Hard-switched Turn Off Waveforms

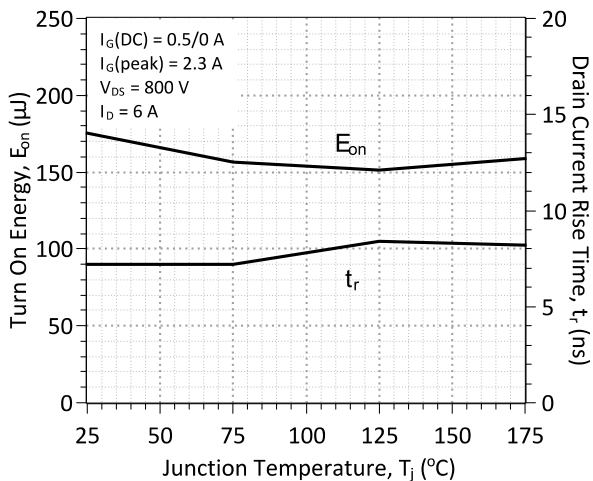


Figure 11: Typical Turn On Energy Losses and Switching Times vs. Temperature

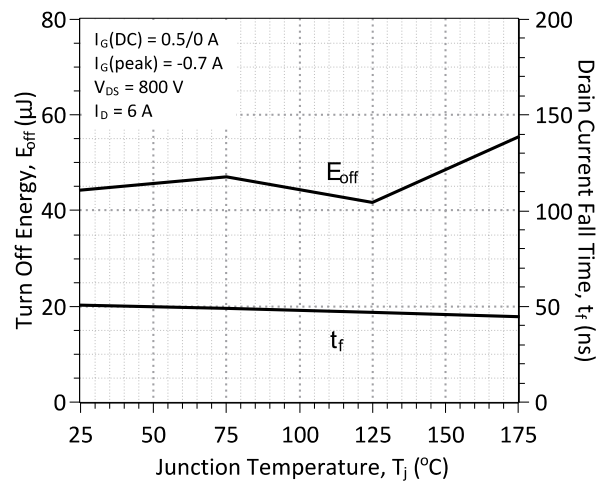


Figure 12: Typical Turn Off Energy Losses and Switching Times vs. Temperature

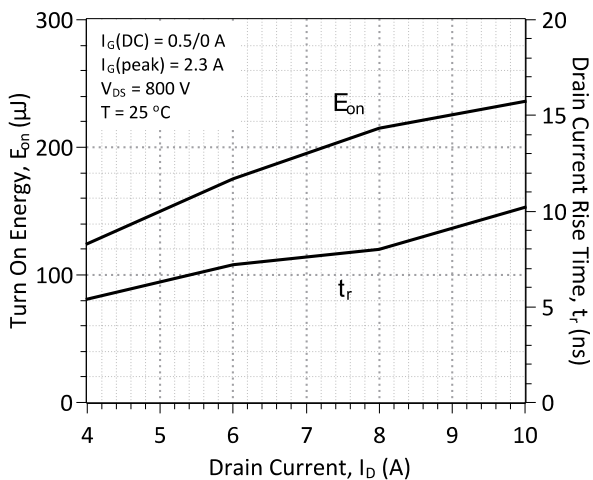


Figure 13: Typical Turn On Energy Losses vs. Drain Current

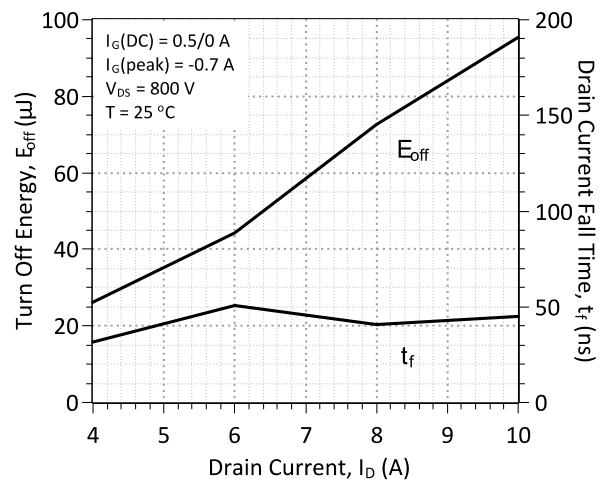


Figure 14: Typical Turn Off Energy Losses vs. Drain Current

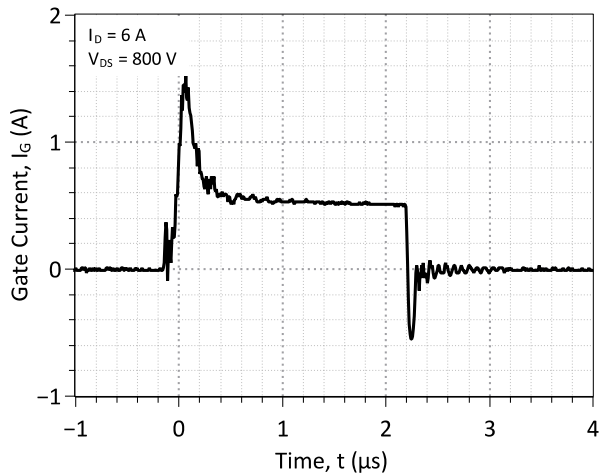


Figure 15: Typical Gate Current Waveform

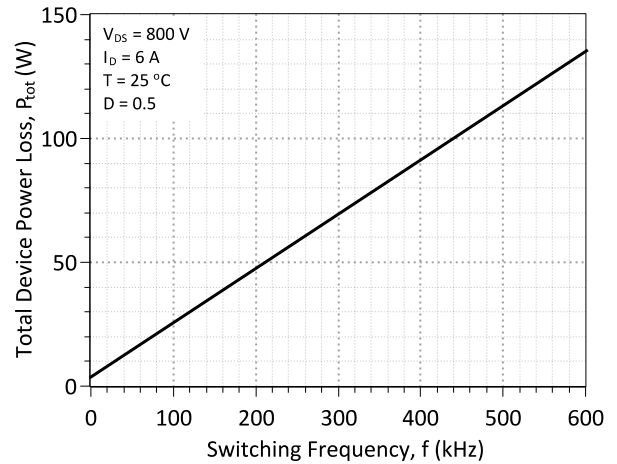


Figure 16: Typical Hard Switched Device Power Loss vs. Switching Frequency¹

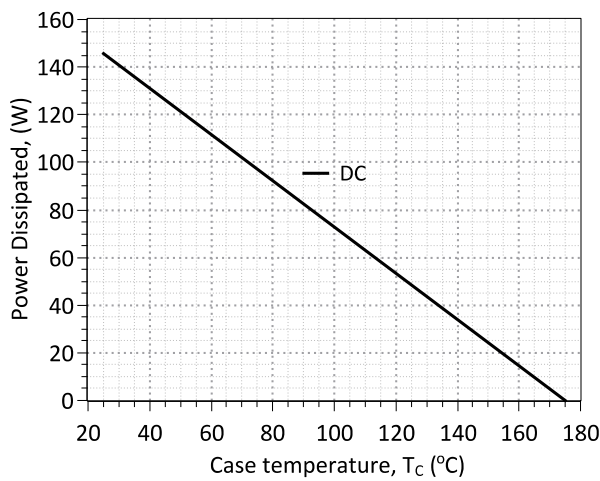


Figure 17: Power Derating Curve

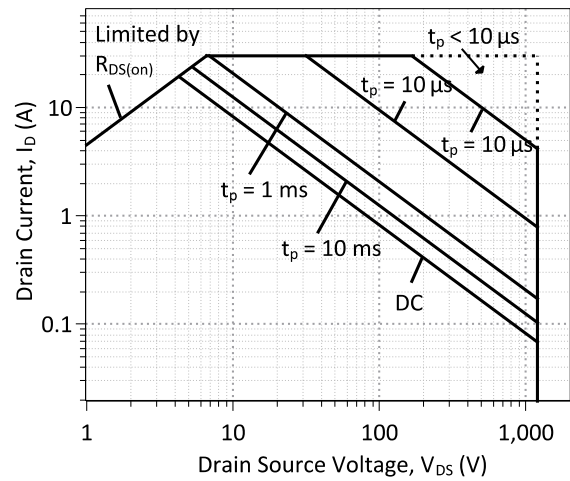


Figure 18: Forward Bias Safe Operating Area

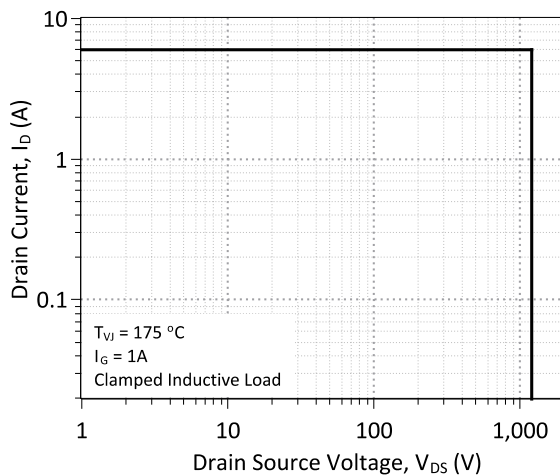


Figure 19: Turn-Off Safe Operating Area

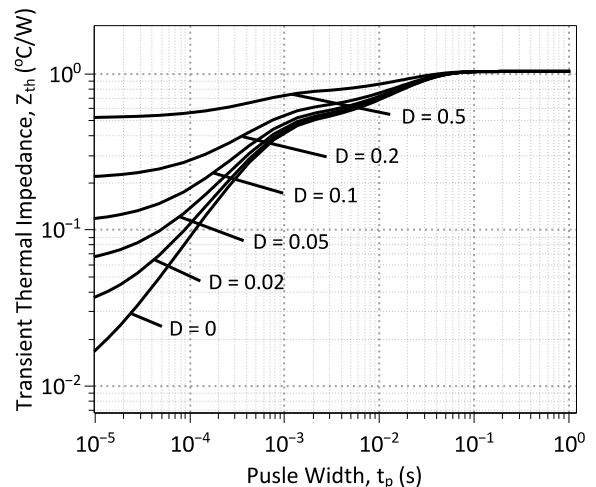


Figure 20: Transient Thermal Impedance

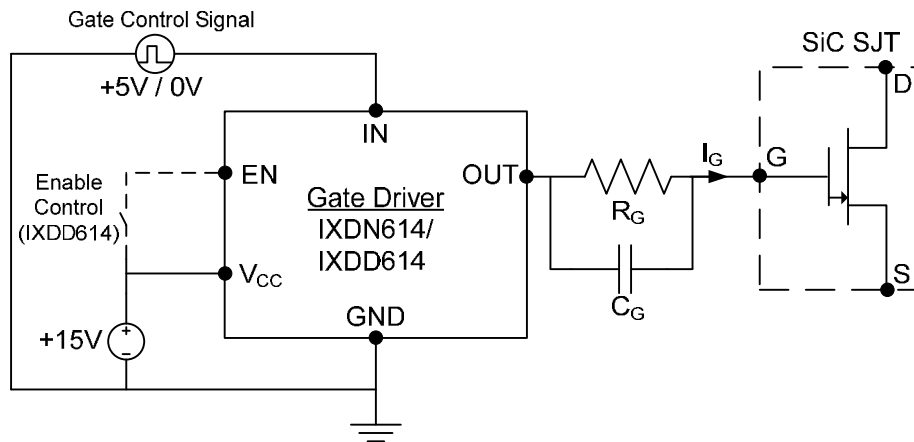
¹ – Representative values based on device switching energy loss. Actual losses will depend on gate drive conditions, device load, and circuit topology.

Gate Drive Technique (Option #1)

To drive the GA06JT12-247 with the lowest gate drive losses, please refer to the dual voltage source gate drive configuration described in Application Note AN-10B (<http://www.genesicsemi.com/index.php/references/notes>).

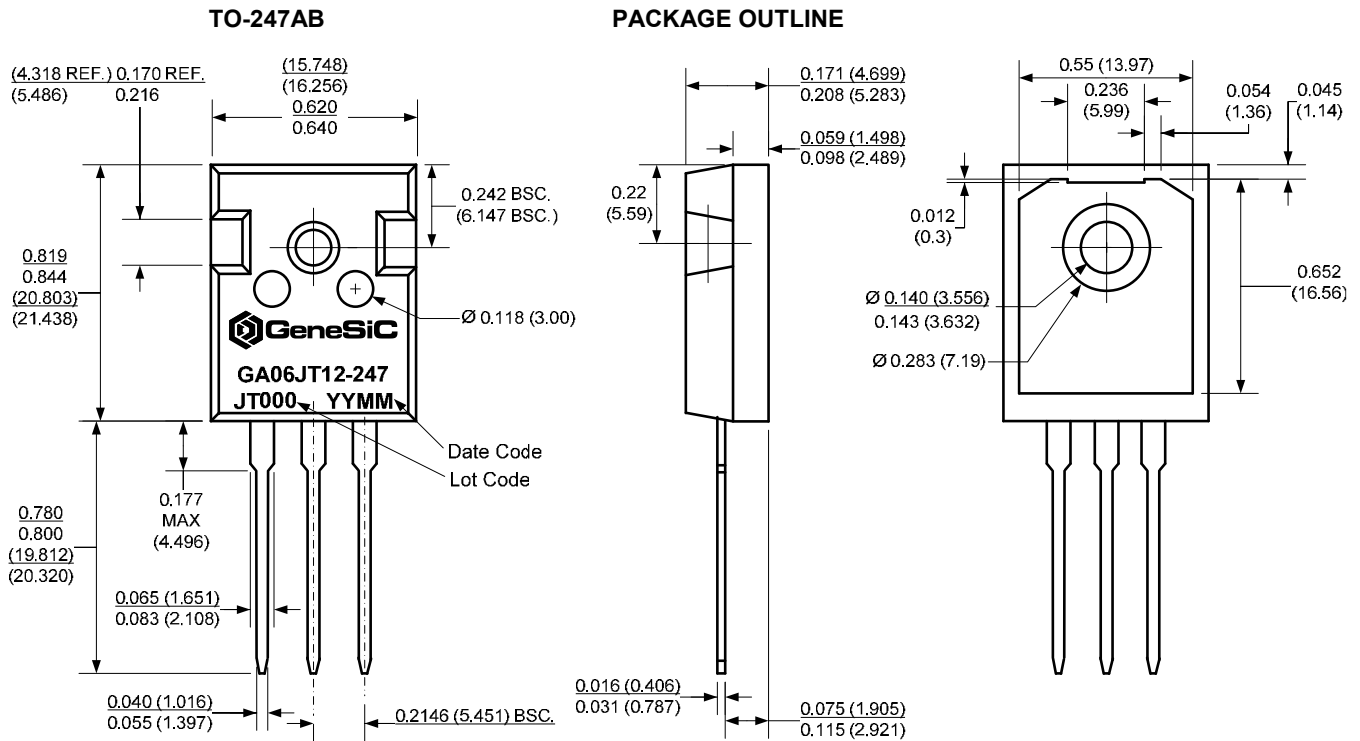
Gate Drive Technique (Option #2)

The GA06JT12-247 can be effectively driven using the IXYS IXDN614 / IXDD614 non-inverting gate driver IC or a comparable product. A typical gate driver configuration along with component values using this driver is offered below. Additional information is available in GeneSiC Application Note AN-10A and from the manufacturer at www.ixys.com.


Figure 21: Gate Diver Configuration (Option #2)

| Parameter | Symbol | Conditions | Values | | | Unit |
|--|-----------|---|----------------|----------------|----------------|----------|
| | | | min. | typ. | max. | |
| Option #1 Gate Drive Conditions (IXDD614/IXDN614) | | | | | | |
| Supply Voltage, High Side Driver | V_{CC} | V_{GH} | 15 | 20 | 30 | V |
| Supply Voltage, Low Side Driver | V_{CC} | V_{GL} | 5 | 6 | | V |
| Off State Voltage, Both Drivers | GND | V_{EE} | | -5 | 0 | V |
| Gate Control Input Signal, Low | IN | | -5.0 | 0 | 0.8 | V |
| Gate Control Input Signal, High | IN | | 4 | 5.0 | $V_{CC}+0.3$ | V |
| Enable, Low | EN | IXDD614 Only | | | $1/3 * V_{CC}$ | V |
| Enable, High | EN | IXDD614 Only | | $2/3 * V_{CC}$ | | V |
| Output Voltage, Low | V_{OUT} | | | | 0.025 | V |
| Output Voltage, High | V_{OUT} | | $V_{CC}-0.025$ | | | V |
| Output Current, Peak | I_{OUT} | Package Limited | | | 14 | A |
| Output Current, Continuous | I_{OUT} | | | 0.5 | 4.0 | A |
| Passive Gate Components | | | | | | |
| Gate Resistance | R_G | $V_{GL} = 6.0 \text{ V}, I_G \approx 0.5 \text{ A}$ | | 1.6 | 5 | Ω |
| Gate Capacitance | C_G | $V_{GH} = 20 \text{ V}, I_{G,pk} \approx 2.0 \text{ A}$ | 5 | 9 | | nF |

Package Dimensions:



- NOTE**
1. CONTROLLED DIMENSION IS INCH. DIMENSION IN BRACKET IS MILLIMETER.
 2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS

| Revision History | | | |
|------------------|----------|------------------------------------|------------|
| Date | Revision | Comments | Supersedes |
| 2013/11/13 | 4 | Updated Electrical Characteristics | |
| 2013/08/23 | 3 | Updated Switching Characteristics | |
| 2013/06/24 | 2 | Updated Electrical Characteristics | |
| 2013/02/21 | 1 | Revised Electrical Characteristics | |
| 2012/11/30 | 0 | Initial Release | |

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SPICE Model Parameters

Copy the following code into a SPICE software program for simulation of the GA06JT12 SJT device.

```
*      MODEL OF GeneSiC Semiconductor Inc.
*
*      $Revision:   1.0           $
*      $Date:      26-AUG-2013   $
*
*      GeneSiC Semiconductor Inc.
*      43670 Trade Center Place Ste. 155
*      Dulles, VA 20166
*      http://www.genesicsemi.com/index.php/sic-products/sjt
*
*      COPYRIGHT (C) 2013 GeneSiC Semiconductor Inc.
*      ALL RIGHTS RESERVED
*
*      These models are provided "AS IS, WHERE IS, AND WITH NO WARRANTY
*      OF ANY KIND EITHER EXPRESSED OR IMPLIED, INCLUDING BUT NOT LIMITED
*      TO ANY IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A
*      PARTICULAR PURPOSE."
*      Models accurate up to 2 times rated drain current.
*
.model GA06JT12 NPN
+ IS      5.08E-47
+ ISE     1.26E-28
+ EG      3.2
+ BF      58.31
+ BR      0.55
+ IKF     200
+ NF      1
+ NE      1.892
+ RB      0.26
+ RE      0.1039
+ RC      0.06188
+ CJC     2.73E-10
+ VJC     3.04
+ MJC     0.448
+ CJE     6.86E-10
+ VJE     2.89
+ MJE     0.466
+ XTI     3
+ XTB     -1.33
+ TRC1    1.90E-2
+ VCEO    1200
+ ICRATING 6
+ MFG     GeneSiC_Semiconductor
*
*      End of GA06JT12 SPICE Model
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